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Unknown

LIST OF RELATED ART CITED BY APPLICANT
(Use several sheets if necessary)

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U.S. PATENT DOCUMENTS

Examiner's Initials	Document Number	Date	Name	Class	Subclass	Filing Date If appropriate
	AA					
	AB					
	AC					
	AD					
	AE					
	AF					
	AG					
	AH					
	AI					

FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
TC	AJ	EP 0 786 725	30 July 1997	Europe			
TC	AK	DE 196 10 847	30 April 1997	Germany			
TC	AL	DE 195 30 647	23 January 1997	Germany			
	AM						
	AN						
	AO						
	AP						

OTHER RELATED ART (Including Author, Title, Date, Pertinent Pages, Etc.)

TC	AQ	S. Yamada, et al.; "SOFTWARE RELIABILITY GROWTH MODELING: MODELS AND APPLICATIONS"; IEEE Transactions on Software Engineering, Vol. SE-11, No. 12, December 1985, pages 1431-1437.
TC	AR	W.K. Ehrlich, et al.; "APPLICATION OF SOFTWARE RELIABILITY MODELING TO PRODUCT QUALITY AND TEST PROCESS"; Proceedings of the International Conference on Software Engineering, US.; Los Alamitos, IEEE, Comp. Soc. Press. Bd. CONF. 12, 1990, pages 108-116.
TC	AS	Anonymous: "STOCHASTIC SIMULATOR OF SOFTWARE DEVELOPMENT PROCESS, February 1978, IBM Technical Disclosure Bulletin, Vol. 20, No. 9, February 1978, pages 3691-3692.
TC	AT	S.I. Resnick: "ADVENTURES IN STOCHASTIC PROCESSES", Birkhaeuser, Boston, 1992, ISBN 3-7643-3591-2, pages 303-317.
TC	AU	P. Brately, et al "A Guide to Simulation" Springer Verlag, 2, Auflage, 1987, Chapter 4, Rational Choice of Input Distributions, pages 124-191.
	AV	
	AW	
	AX	
	AY	

Examiner TRANG CAO

Date Considered

02/19/03

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.